

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
HUANG, WEI-FENG

Examiner

EUENG-NAN YEH

Art Unit

2624

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*	B	US-7,199,825	04-2007	Guamera et al.	348/272
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	D	US-			
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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